Notice of References Cited Application/Control No. | Applicant(s)/Patent Under Reexamination FUNK, DAVID Examiner | Art Unit | Page 1 of 1

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|------------------|----------------|
| | Α | US-6,801,949 B1 | 10-2004 | Bruck et al. | 709/232 |
| | В | US-6,751,191 B1 | 06-2004 | Kanekar et al. | 370/217 |
| | С | US-6,616,350 B1 | 09-2003 | de Boer et al. | 398/9 |
| | D | US-2002/0166080 A1 | 11-2002 | ATTANASIO et al. | 714/15 |
| | E | US- | | | |
| | F | US- | | | |
| | G | US- | | | |
| | Н | US- | | | |
| | 1 | US- | | | |
| | J | US- | | | |
| | К | US- | | | |
| | L | US- | | | |
| | М | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
| | 0 | | | | | |
| | Р | | | | | |
| | α | | | | | |
| | R | | | • | | ÷ |
| | s | | | | | |
| | Т | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | v | |
| | w | |
| | x | |

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.